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PERFORMANCE CHECKSHEET

Model: AVR-EB2A-B-VXI-AC03
Type: Semiconductor Device Tester
S.N.: 13195
Date: September 8, 2014

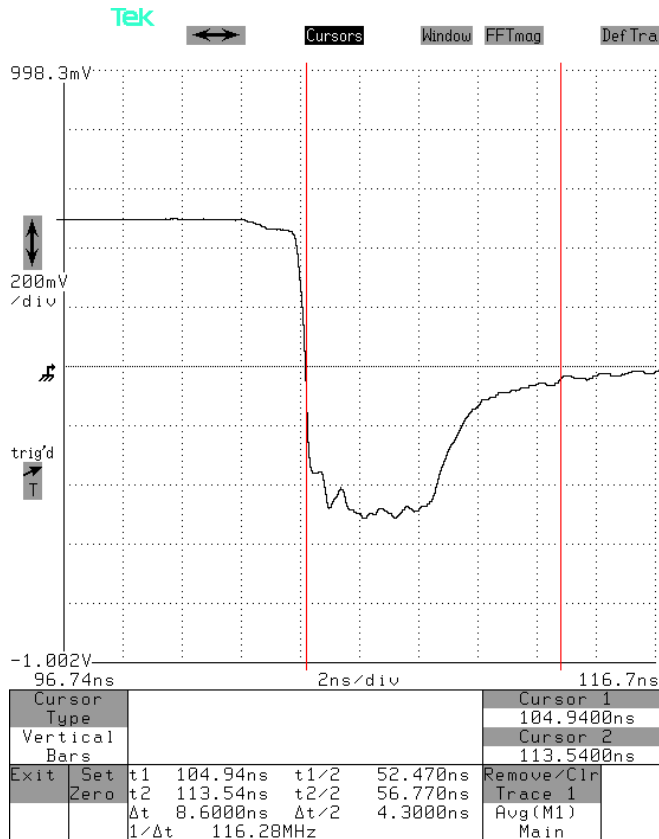
Output Amplitude: to +100 mA, -100 mA
Pulse Width (FWHM): 200 ns
Switching Time,
+ to -, 10%-90%: ≤ 300 ps (at mainframe)
PRF: 1 - 10 kHz
Jitter, Stability: OK
Prime Power: 100-240V AC, 50-60 Hz.

Basic specifications: →

Test Waveforms

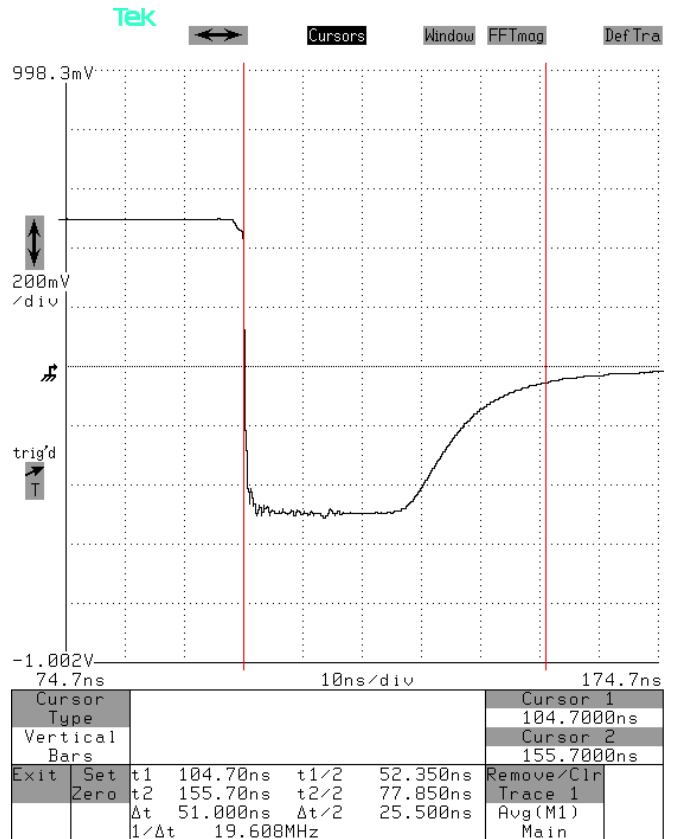
With a 1N4148 installed in the AVX-CA-AR1 test jig, 40 mA/div, 2 ns/div:

With a 1N5811US installed in the AVX-CA-AR1 test jig, 40 mA/div, 10 ns/div:



I_F = +100 mA, I_R = - 100 mA

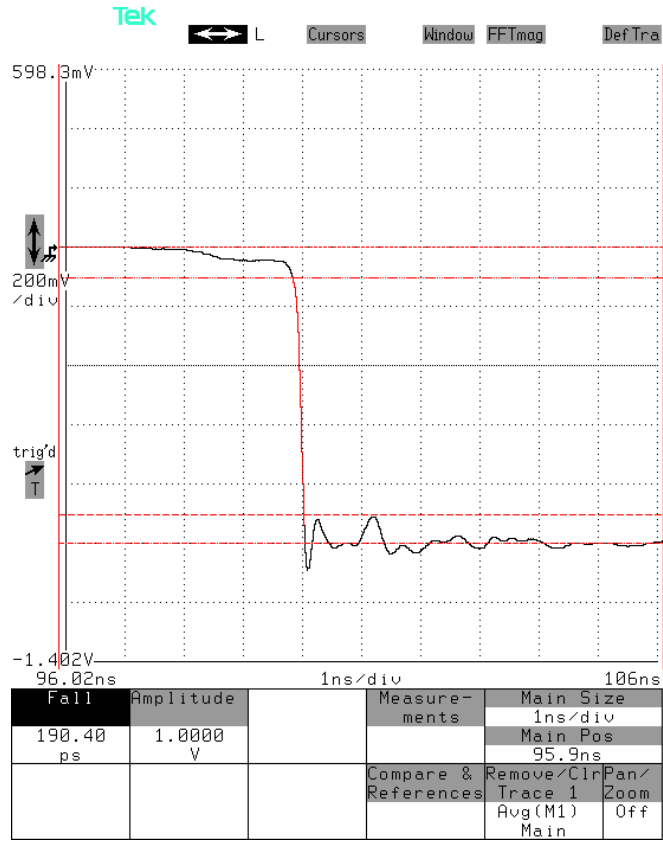
Measured t_{RR} = 8.6 ns.



I_F = +100 mA, I_R = - 100 mA

Measured t_{RR} = 51 ns.

Pulse output directly from mainframe, with the test jig bypassed (2 V/div, 1 ns/div):



Shows a 10%-90% transition time of 190.4 ps.